# IS41C16105C IS41LV16105C



## 1Mx16 16Mb DRAM WITH FAST PAGE MODE

**FEBRUARY 2012** 

#### **FEATURES**

- TTL compatible inputs and outputs; tristate I/O
- Refresh Interval:
  - 1,024 cycles/16 ms
- · Refresh Mode:
  - RAS-Only, CAS-before-RAS (CBR), and Hidden
- JEDEC standard pinout
- · Single power supply:
  - $-5V \pm 10\%$  (IS41C16105C)
  - $-3.3V \pm 10\%$  (IS41LV16105C)
- Byte Write and Byte Read operation via two CAS
- Industrial Temperature Range -40°C to 85°C

#### DESCRIPTION

The ISSI IS41C16105C and IS41LV16105C are 1,048,576 x 16-bit high-performance CMOS Dynamic Random Access Memories. Fast Page Mode allows 1,024 random accesses within a single row with access cycle time as short as 20 ns per 16-bit word. It is asynchronous, as it does not require a clock signal input to synchronize commands and I/O.

These features make the IS41C16105C and IS41LV16105C ideally suited for high-bandwidth graphics, digital signal processing, high-performance computing systems, and peripheral applications that run without a clock to synchronize with the DRAM.

The IS41C/LV16105C is packaged in a 42-pin 400-mil SOJ and 400-mil 50/44-pin TSOP (Type II).

#### **KEY TIMING PARAMETERS**

| Parameter                             | -50 | Unit |
|---------------------------------------|-----|------|
| Max. RAS Access Time (trac)           | 50  | ns   |
| Max. CAS Access Time (tcac)           | 13  | ns   |
| Max. Column Address Access Time (taa) | 25  | ns   |
| Min. Fast Page Mode Cycle Time (tpc)  | 20  | ns   |
| Min. Read/Write Cycle Time (trc)      | 84  | ns   |

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a.) the risk of injury or damage has been minimized;

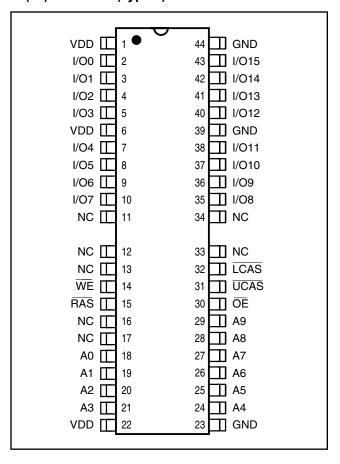
b.) the user assume all such risks; and

c.) potential liability of Integrated Silicon Solution, Inc is adequately protected under the circumstances

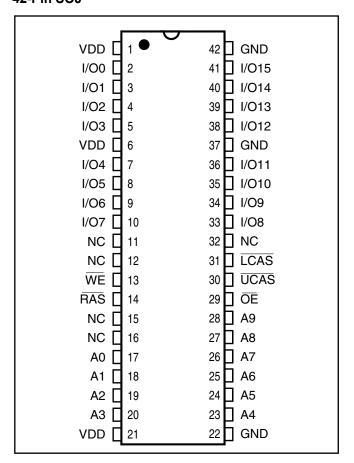


### **PIN CONFIGURATIONS**

## 44(50)-Pin TSOP (Type II)



#### 42-Pin SOJ

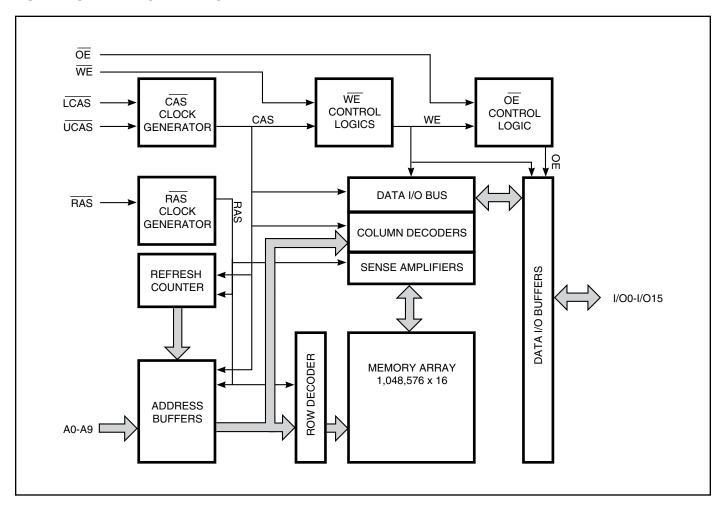


### PIN DESCRIPTIONS

| A0-A9           | Address Inputs              |
|-----------------|-----------------------------|
| I/O0-15         | Data Inputs/Outputs         |
| WE              | Write Enable                |
| ŌĒ              | Output Enable               |
| RAS             | Row Address Strobe          |
| UCAS            | Upper Column Address Strobe |
| LCAS            | Lower Column Address Strobe |
| V <sub>DD</sub> | Power                       |
| GND             | Ground                      |
| NC              | No Connection               |



## **FUNCTIONAL BLOCK DIAGRAM**



## IS41C16105C IS41LV16105C



## TRUTH TABLE(5)

| Function                   |                        | $\overline{RAS}$              | <b>LCAS</b> | <b>UCAS</b> | $\overline{\text{WE}}$ | ŌĒ  | Address tr/tc | I/O                                    |
|----------------------------|------------------------|-------------------------------|-------------|-------------|------------------------|-----|---------------|--|
| Standby                    |                        | Н                             | Х           | Х           | Χ                      | Х   | Х             | High-Z                                 |
| Read: Word                 |                        | L                             | L           | L           | Н                      | L   | ROW/COL       | Douт                                   |
| Read: Lower Byte           |                        | L                             | L           | Н           | Н                      | L   | ROW/COL       | Lower Byte, Dout<br>Upper Byte, High-Z |
| Read: Upper Byte           |                        | L                             | Н           | L           | Н                      | L   | ROW/COL       | Lower Byte, High-Z<br>Upper Byte, Dout |
| Write: Word (Early         | / Write)               | L                             | L           | L           | L                      | Х   | ROW/COL       | Din                                    |
| Write: Lower Byte          | (Early Write)          | L                             | L           | Н           | L                      | Х   | ROW/COL       | Lower Byte, DIN<br>Upper Byte, High-Z  |
| Write: Upper Byte          | (Early Write)          | L                             | Н           | L           | L                      | Х   | ROW/COL       | Lower Byte, High-Z<br>Upper Byte, DIN  |
| Read-Write(1,2)            |                        | L                             | L           | L           | H→L                    | L→H | ROW/COL       | Dоит, DIN                              |
| Hidden Refresh             | Read <sup>(2)</sup>    | L→H→L                         | L           | L           | Н                      | L   | ROW/COL       | Dout                                   |
|                            | Write <sup>(1,3)</sup> | $L\rightarrow H\rightarrow L$ | L           | L           | L                      | Χ   | ROW/COL       | Douт                                   |
| RAS-Only Refresh           | า                      | L                             | Н           | Н           | Х                      | Х   | ROW/NA        | High-Z                                 |
| CBR Refresh <sup>(4)</sup> |                        | H→L                           | L           | L           | Н                      | Χ   | Х             | High-Z                                 |

- These WRITE cycles may also be BYTE WRITE cycles (either LCAS or UCAS active).
   These READ cycles may also be BYTE READ cycles (either LCAS or UCAS active).
- 3. EARLY WRITE only.
- 4. At least one of the two CAS signals must be active (LCAS or UCAS).
- 5. Commands valid only after initialization.



## **Functional Description**

The IS41C/LV16105C is a CMOS DRAM optimized for high-speed bandwidth, low power applications. During READ or WRITE cycles, each bit is uniquely addressed through the 16 address bits. These are entered ten bits (A0-A9) at a time. The row address is latched by the Row Address Strobe (RAS). The column address is latched by the Column Address Strobe (CAS). RAS is used to latch the first nine bits and  $\overline{CAS}$  is used the latter nine bits.

The IS41C/LV16105C has two CAS controls, LCAS and UCAS. The LCAS and UCAS inputs internally generates a CAS signal functioning in an identical manner to the single CAS input on the other 1M x 16 DRAMs. The key difference is that each CAS controls its corresponding I/O tristate logic (in conjunction with  $\overline{OE}$  and  $\overline{WE}$  and  $\overline{RAS}$ ). LCAS controls I/O0 through I/O7 and UCAS controls I/ O8 through I/O15.

The IS41C/LV16105C CAS function is determined by the first CAS (LCAS or UCAS) transitioning LOW and the last transitioning back HIGH. The two CAS controls give the IS41C16105C and IS41LV16105C both BYTE READ and BYTE WRITE cycle capabilities.

## **Memory Cycle**

A memory cycle is initiated by bring RAS LOW and it is terminated by returning both RAS and CAS HIGH. To ensures proper device operation and data integrity any memory cycle, once initiated, must not be ended or aborted before the minimum tras time has expired. A new cycle must not be initiated until the minimum precharge time trp, tcp has elapsed.

### Read Cycle

A read cycle is initiated by the falling edge of  $\overline{CAS}$  or  $\overline{OE}$ , whichever occurs last, while holding WE HIGH. The column address must be held for a minimum time specified by tar. Data Out becomes valid only when trac, taa, tcac and toea are all satisfied. As a result, the access time is dependent on the timing relationships between these parameters.

## **Write Cycle**

A write cycle is initiated by the falling edge of CAS and WE, whichever occurs last. The input data must be valid at or before the falling edge of  $\overline{\text{CAS}}$  or  $\overline{\text{WE}}$ , whichever occurs last.

## Refresh Cycle

To retain data, 1,024 refresh cycles are required in each 16 ms period. There are two ways to refresh the mem-

- 1. By clocking each of the 1,024 row addresses (A0 through A9) with RAS at least once every tree max. Any read, write, read-modify-write or RAS-only cycle refreshes the addressed row.
- 2. Using a CAS-before-RAS refresh cycle. CAS-before-RAS refresh is activated by the falling edge of RAS, while holding CAS LOW. In CAS-before-RAS refresh cycle, an internal 9-bit counter provides the row addresses and the external address inputs are ignored.

CAS-before-RAS is a refresh-only mode and no data access or device selection is allowed. Thus, the output remains in the High-Z state during the cycle.

#### Power-On

During Power-On, RAS, UCAS, LCAS, and WE must all track with VDD (HIGH) to avoid current surges, and allow initialization to continue. An initial pause of 200 µs is required followed by a minimum of eight initialization cycles (any combination of cycles containing a RAS signal).



## ABSOLUTE MAXIMUM RATINGS(1)

| Symbol | Parameters                         |      | Rating       | Unit |  |
|--------|------------------------------------|------|--------------|------|--|
| VT     | Voltage on Any Pin Relative to GND | 5V   | -1.0 to +7.0 | V    |  |
|        |                                    | 3.3V | -0.5 to +4.6 |      |  |
| VDD    | Supply Voltage                     | 5V   | -1.0 to +7.0 | V    |  |
|        |                                    | 3.3V | -0.5 to +4.6 |      |  |
| Іоит   | Output Current                     |      | 50           | mA   |  |
| PD     | Power Dissipation                  |      | 1            | W    |  |
| TA     | Industrial Temperature             |      | -40 to +85   | °C   |  |
| Тѕтс   | Storage Temperature                |      | -55 to +125  | °C   |  |

#### Note:

## RECOMMENDED OPERATING CONDITIONS (Voltages are referenced to GND.)

| Symbol          | Parameter                 | Test Condition   |            | Min.         | Тур.       | Max.                             | Unit |
|-----------------|---------------------------|--|------------|--------------|------------|----------------------------------|------|
| V <sub>DD</sub> | Supply Voltage            |  | 5V<br>3.3V | 4.5<br>3.0   | 5.0<br>3.3 | 5.5<br>3.6                       | V    |
| ViH             | Input High Voltage        |  | 5V<br>3.3V | 2.4<br>2.0   | _          | $V_{DD} + 1.0$<br>$V_{DD} + 0.3$ | V    |
| VIL             | Input Low Voltage         |  | 5V<br>3.3V | -1.0<br>-0.3 | _          | 0.8<br>0.8                       | V    |
| lı∟             | Input Leakage Current     | Any input $0V \le V_{IN} \le V_{DD}$<br>Other inputs not under test = $0V$ |            | <b>–</b> 5   |            | 5                                | μΑ   |
| lio             | Output Leakage Current    | Output is disabled (Hi-Z) $0V \le V_{OUT} \le V_{DD}$                      |            | <b>–</b> 5   |            | 5                                | μA   |
| Vон             | Output High Voltage Level | Іон = –5.0 mA<br>Іон = –2.0 mA   | 5V<br>3.3V | 2.4<br>2.4   |            | _                                | V    |
| Vol             | Output Low Voltage Level  | IoL = 4.2 mA<br>IoL = 2.0 mA   | 5V<br>3.3V | _            |            | 0.4<br>0.4                       | V    |

### CAPACITANCE(1,2)

| Symbol | Parameter                                  | Max. | Unit |
|--------|--|------|------|
| CIN1   | Input Capacitance: A0-A9                   | 5    | pF   |
| CIN2   | Input Capacitance: RAS, UCAS, LCAS, WE, OE | 7    | pF   |
| Cio    | Data Input/Output Capacitance: I/O0-I/O15  | 7    | pF   |

- 1. Tested initially and after any design or process changes that may affect these parameters.
- 2. Test conditions: TA = 25°C, f = 1 MHz,

Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the
device. This is a stress rating only and functional operation of the device at these or any other conditions above
those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum
rating conditions for extended periods may affect reliability.



## **ELECTRICAL CHARACTERISTICS(1)**

(Recommended Operating Conditions unless otherwise noted.)

| Symbol           | Parameter                            | Test Condition   | VDD/Speed | Min. | Max. | Unit |
|------------------|--------------------------------------|--|-----------|------|------|------|
| I <sub>DD1</sub> | Standby Current: TTL                 | $\overline{RAS}$ , $\overline{LCAS}$ , $\overline{UCAS} \ge VIH$           |           |      |      |      |
|                  | •                                    |  | 5V        |      | 2    | mΑ   |
|                  |                                      |  | 3.3V      | _    | 2    |      |
| I <sub>DD2</sub> | Standby Current: CMOS                | $\overline{RAS}$ , $\overline{LCAS}$ , $\overline{UCAS} \ge V_{DD} - 0.2V$ | 5V        | _    | 1    | mΑ   |
|                  | •                                    |  | 3.3V      | _    | 1    |      |
| IDD3             | Operating Current:                   | RAS, LCAS, UCAS,   | 5V        |      | 90   | mΑ   |
|                  | Random Read/Write <sup>(2,3,4)</sup> | Address Cycling, trc = trc (min.)  | 3.3V      | _    | 90   |      |
|                  | Average Power Supply Current         |  |           |      |      |      |
| IDD4             | Operating Current:                   | $\overline{RAS} = V_{IL}, \overline{LCAS}, \overline{UCAS},$               | 5V        | _    | 30   | mΑ   |
|                  | Fast Page Mode <sup>(2,3,4)</sup>    | Cycling tpc = tpc (min.)   | 3.3V      |      | 30   |      |
|                  | Average Power Supply Current         |  |           |      |      |      |
| IDD5             | Refresh Current:                     | $\overline{RAS}$ Cycling, $\overline{LCAS}$ , $\overline{UCAS} \ge VIH$    | 5V        | _    | 60   | mΑ   |
|                  | RAS-Only <sup>(2,3)</sup>            | trc = trc (min.)   | 3.3V      |      | 60   |      |
|                  | Average Power Supply Current         |  |           |      |      |      |
| IDD6             | Refresh Current:                     | RAS, LCAS, UCAS Cycling  | 5V        | _    | 60   | mΑ   |
|                  | CBR <sup>(2,3,5)</sup>               | trc = trc (min.)   | 3.3V      |      | 60   |      |
|                  | Average Power Supply Current         | , .  |           |      |      |      |

<sup>1.</sup> An initial pause of 200 µs is required after power-up followed by eight RAS refresh cycles (RAS-Only or CBR) before proper device operation is assured. The eight RAS cycles wake-up should be repeated any time the tree refresh requirement is exceeded.

<sup>2.</sup> Dependent on cycle rates.

<sup>3.</sup> Specified values are obtained with minimum cycle time and the output open.

<sup>4.</sup> Column-address is changed once each Fast page cycle.

<sup>5.</sup> Enables on-chip refresh and address counters.



## **AC CHARACTERISTICS**(1,2,3,4,5,6)

(Recommended Operating Conditions unless otherwise noted.)

|               |  | -50  |          | -(   | 60   |       |
|---------------|--|------|----------|------|------|-------|
| Symbol        | Parameter  | Min. | Max.     | Min. | Max. | Units |
| trc           | Random READ or WRITE Cycle Time                            | 84   | _        | 104  | _    | ns    |
| trac          | Access Time from RAS(6, 7)                                 | _    | 50       | _    | 60   | ns    |
| tcac          | Access Time from CAS(6, 8, 15)                             | _    | 13       | _    | 15   | ns    |
| taa           | Access Time from Column-Address <sup>(6)</sup>             | _    | 25       | _    | 30   | ns    |
| tras          | RAS Pulse Width  | 50   | 10K      | 60   | 10K  | ns    |
| <b>t</b> RP   | RAS Precharge Time   | 30   | _        | 40   | _    | ns    |
| tcas          | CAS Pulse Width(26)  | 8    | 10K      | 10   | 10K  | ns    |
| <b>t</b> CP   | CAS Precharge Time <sup>(9, 25)</sup>                      | 9    | _        | 9    | _    | ns    |
| <b>t</b> csH  | CAS Hold Time (21)   | 38   | _        | 40   | _    | ns    |
| trcd          | RAS to CAS Delay Time(10, 20)                              | 12   | 37       | 14   | 45   | ns    |
| tasr          | Row-Address Setup Time                                     | 0    | _        | 0    | _    | ns    |
| trah          | Row-Address Hold Time                                      | 8    | _        | 10   | _    | ns    |
| tasc          | Column-Address Setup Time(20)                              | 0    | _        | 0    | _    | ns    |
| tcah          | Column-Address Hold Time(20)                               | 8    | _        | 10   | _    | ns    |
| tar           | Column-Address Hold Time (referenced to RAS)               | 30   | _        | 40   | _    | ns    |
| tRAD          | RAS to Column-Address Delay Time(11)                       | 10   | 25       | 12   | 30   | ns    |
| tRAL          | Column-Address to RAS Lead Time                            | 25   | _        | 30   | _    | ns    |
| <b>t</b> RPC  | RAS to CAS Precharge Time                                  | 5    | _        | 5    | _    | ns    |
| trsh          | RAS Hold Time <sup>(27)</sup>                              | 8    | _        | 10   | _    | ns    |
| <b>t</b> RHCP | RAS Hold Time from CAS Precharge                           | 37   | _        | 37   | _    | ns    |
| tclz          | CAS to Output in Low-Z(15, 29)                             | 0    | _        | 0    | _    | ns    |
| tCRP          | CAS to RAS Precharge Time(21)                              | 5    | _        | 5    | _    | ns    |
| top           | Output Disable Time(19, 28, 29)                            | 3    | 15       | 3    | 15   | ns    |
| toe           | Output Enable Time(15, 16)                                 | _    | 13       | _    | 15   | ns    |
| toed          | Output Enable Data Delay (Write)                           | 20   | _        | 20   | _    | ns    |
| toehc         | OE HIGH Hold Time from CAS HIGH                            | 5    | _        | 5    | _    | ns    |
| toep          | OE HIGH Pulse Width  | 10   | _        | 10   | _    | ns    |
| toes          | OE LOW to CAS HIGH Setup Time                              | 5    | _        | 5    | _    | ns    |
| trcs          | Read Command Setup Time(17, 20)                            | 0    | _        | 0    | _    | ns    |
| trrh          | Read Command Hold Time (referenced to RAS) <sup>(12)</sup> | 0    | _        | 0    | _    | ns    |
| <b>t</b> RCH  | Read Command Hold Time (referenced to CAS)(12, 17, 21)     | 0    | <u>—</u> | 0    | _    | ns    |
| <b>t</b> wcH  | Write Command Hold Time(17, 27)                            | 8    |          | 10   | _    | ns    |
|               |  |      |          |      |      |       |



## AC CHARACTERISTICS (Continued)(1,2,3,4,5,6)

(Recommended Operating Conditions unless otherwise noted.)

|               |  | -    | 50   | -(   |      |       |
|---------------|--|------|------|------|------|-------|
| Symbol        | Parameter  | Min. | Max. | Min. | Max. | Units |
| twcr          | Write Command Hold Time (referenced to RAS) <sup>(17)</sup>                          | 40   | _    | 50   | _    | ns    |
| twp           | Write Command Pulse Width(17)  | 8    | _    | 10   | _    | ns    |
| twpz          | WE Pulse Widths to Disable Outputs   | 10   | _    | 10   | _    | ns    |
| trwL          | Write Command to RAS Lead Time(17)   | 13   | _    | 15   | _    | ns    |
| tcwL          | Write Command to CAS Lead Time(17, 21)   | 8    | _    | 10   | _    | ns    |
| twcs          | Write Command Setup Time(14, 17, 20)   | 0    | _    | 0    | _    | ns    |
| <b>t</b> DHR  | Data-in Hold Time (referenced to RAS)  | 39   | _    | 39   | _    | ns    |
| tach          | Column-Address Setup Time to CAS Precharge during WRITE Cycle                        | 15   | _    | 15   | _    | ns    |
| <b>t</b> oeh  | OE Hold Time from WE during READ-MODIFY-WRITE cycle <sup>(18)</sup>                  | 8    | _    | 10   | _    | ns    |
| tos           | Data-In Setup Time(15, 22)   | 0    | _    | 0    | _    | ns    |
| <b>t</b> DH   | Data-In Hold Time(15, 22)  | 8    | _    | 10   | _    | ns    |
| trwc          | READ-MODIFY-WRITE Cycle Time   | 108  | _    | 133  | _    | ns    |
| trwd          | RAS to WE Delay Time during READ-MODIFY-WRITE Cycle(14)                              | 64   | _    | 77   | _    | ns    |
| tcwp          | CAS to WE Delay Time(14, 20)   | 26   | _    | 32   | _    | ns    |
| tawd          | Column-Address to WE Delay Time(14)  | 39   | _    | 47   | _    | ns    |
| tpc           | Fast Page Mode READ or WRITE Cycle Time <sup>(24)</sup>                              | 20   | _    | 25   | _    | ns    |
| trasp         | RAS Pulse Width  | 50   | 100K | 60   | 100K | ns    |
| <b>t</b> CPA  | Access Time from CAS Precharge(15)   | _    | 30   | _    | 35   | ns    |
| tprwc         | READ-WRITE Cycle Time(24)  | 56   | _    | 68   | _    | ns    |
| tсон          | Data Output Hold after CAS LOW   | 5    | _    | 5    | _    | ns    |
| toff          | Output Buffer Turn-Off Delay from CAS or RAS(13,15,19,29)                            | 1.6  | 12   | 1.6  | 15   | ns    |
| twnz          | Output Disable Delay from WE   | 3    | 10   | 3    | 10   | ns    |
| <b>t</b> CLCH | Last <del>CAS</del> going LOW to First <del>CAS</del> returning HIGH <sup>(23)</sup> | 10   | _    | 10   | _    | ns    |
| tcsr          | CAS Setup Time (CBR REFRESH)(30, 20)   | 5    | _    | 5    | _    | ns    |
| tchr          | CAS Hold Time (CBR REFRESH)(30, 21)  | 8    |      | 10   | _    | ns    |
| tord          | OE Setup Time prior to RAS during HIDDEN REFRESH Cycle                               | 0    | _    | 0    | _    | ns    |
| twrp          | WE Setup Time (CBR Refresh)  | 5    | _    | 5    | _    | ns    |
| twrh          | WE Hold Time (CBR Refresh)   | 8    | _    | 10   | _    | ns    |
| tref          | Auto Refresh Period (1,024 Cycles)   | _    | 16   | _    | 16   | ms    |
| tτ            | Transition Time (Rise or Fall) <sup>(2, 3)</sup>                                     | 1    | 50   | 1    | 50   | ns    |

The -60 timing parameters are shown for reference only. The -50 speed option supports 50ns and 60ns timing specifications.



#### **AC TEST CONDITIONS**

Output load: Two TTL Loads and 100 pF ( $VDD = 5.0V \pm 10\%$ ) One TTL Load and 50 pF ( $VDD = 3.3V \pm 10\%$ )

Input timing reference levels:  $V_{IH} = 2.4V$ ,  $V_{IL} = 0.8V$  ( $V_{DD} = 5.0V \pm 10\%$ );

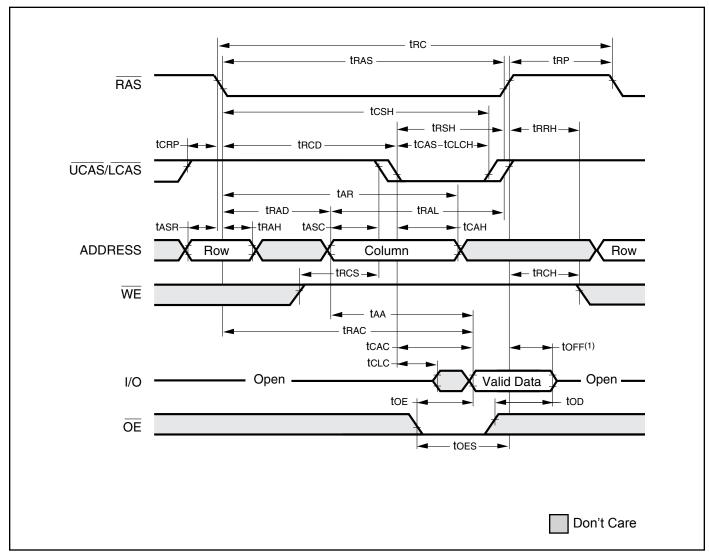
 $V_{IH} = 2.0V$ ,  $V_{IL} = 0.8V$  ( $V_{DD} = 3.3V \pm 10\%$ )

Output timing reference levels: VoH = 2.4V, VoL = 0.4V (VDD =  $5V \pm 10\%$ ,  $3.3V \pm 10\%$ )

- 1. An initial pause of 200 µs is required after power-up followed by eight  $\overline{RAS}$  refresh cycle ( $\overline{RAS}$ -Only or CBR) before proper device operation is assured. The eight  $\overline{RAS}$  cycles wake-up should be repeated any time the tree refresh requirement is exceeded.
- 2. ViH (MIN) and ViL (MAX) are reference levels for measuring timing of input signals. Transition times, are measured between ViH and ViL (or between ViL and ViH) and assume to be 1 ns for all inputs.
- 3. In addition to meeting the transition rate specification, all input signals must transit between V<sub>I</sub>H and V<sub>I</sub>L (or between V<sub>I</sub>L and V<sub>I</sub>H) in <u>a monotonic manner.</u>
- 4. If  $\overline{CAS}$  and  $\overline{RAS}$  = V<sub>IH</sub>, data output is High-Z.
- 5. If  $\overline{CAS} = V_{IL}$ , data output may contain data from the last valid READ cycle.
- 6. Measured with a load equivalent to one TTL gate and 50 pF.
- 7. Assumes that troo troo (MAX). If troo is greater than the maximum recommended value shown in this table, trac will increase by the amount that troo exceeds the value shown.
- 8. Assumes that trcd ž trcd (MAX).
- 9. If  $\overline{\text{CAS}}$  is LOW at the falling edge of  $\overline{\text{RAS}}$ , data out will be maintained from the previous cycle. To initiate a new cycle and clear the data output buffer,  $\overline{\text{CAS}}$  and  $\overline{\text{RAS}}$  must be pulsed for tcp.
- 10. Operation with the tRCD (MAX) limit ensures that tRAC (MAX) can be met. tRCD (MAX) is specified as a reference point only; if tRCD is greater than the specified tRCD (MAX) limit, access time is controlled exclusively by tCAC.
- 11. Operation within the trad (MAX) limit ensures that trad (MAX) can be met. trad (MAX) is specified as a reference point only; if trad is greater than the specified trad (MAX) limit, access time is controlled exclusively by trad.
- 12. Either trich or trich must be satisfied for a READ cycle.
- 13. toff (MAX) defines the time at which the output achieves the open circuit condition; it is not a reference to Voh or Vol.
- 14. twcs, trwo, tawo and tcwd are restrictive operating parameters in LATE WRITE and READ-MODIFY-WRITE cycle only. If twcs ž twcs (MIN), the cycle is an EARLY WRITE cycle and the data output will remain open circuit throughout the entire cycle. If trwd ž trwd (MIN), tawd ž tawd (MIN) and tcwd ž tcwd (MIN), the cycle is a READ-WRITE cycle and the data output will contain data read from the selected cell. If neither of the above conditions is met, the state of I/O (at access time and until CAS and RAS or OE go back to Vih) is indeterminate. OE held HIGH and WE taken LOW after CAS goes LOW result in a LATE WRITE (OE-controlled) cycle.
- 15. Output parameter (I/O) is referenced to corresponding CAS input, I/O0-I/O7 by LCAS and I/O8-I/O15 by UCAS.
- 16. During a READ cycle, if  $\overline{OE}$  is LOW then taken HIGH before  $\overline{CAS}$  goes HIGH, I/O goes open. If  $\overline{OE}$  is tied permanently LOW, a LATE WRITE or READ-MODIFY-WRITE is not possible.
- 17. Write command is defined as  $\overline{\text{WE}}$  going low.
- 18. LATE WRITE and READ-MODIFY-WRITE cycles must have both top and toeh met (OE HIGH during WRITE cycle) in order to ensure that the output buffers will be open during the WRITE cycle. The I/Os will provide the previously written data if CAS remains LOW and OE is taken back to LOW after toeh is met.
- 19. The I/Os are in open during READ cycles once top or toff occur.
- 20. The first  $\chi \overline{\text{CAS}}$  edge to transition LOW.
- 21. The last  $\chi \overline{\text{CAS}}$  edge to transition HIGH.
- 22. These parameters are referenced to CAS leading edge in EARLY WRITE cycles and WE leading edge in LATE WRITE or READ-MODIFY-WRITE cycles.
- 23. Last falling  $\chi \overline{CAS}$  edge to first rising  $\chi \overline{CAS}$  edge.
- 24. Last rising  $\chi \overline{CAS}$  edge to next cycle's last rising  $\chi \overline{CAS}$  edge.
- 25. Last rising  $\chi \overline{\text{CAS}}$  edge to first falling  $\chi \overline{\text{CAS}}$  edge.
- 26. Each χCAS must meet minimum pulse width.
- 27. Last  $\chi \overline{CAS}$  to go LOW.
- 28. I/Os controlled, regardless UCAS and LCAS.
- 29. The 3 ns minimum is a parameter guaranteed by design.
- 30. Enables on-chip refresh and address counters.



## **FAST-PAGE-MODE READ CYCLE**

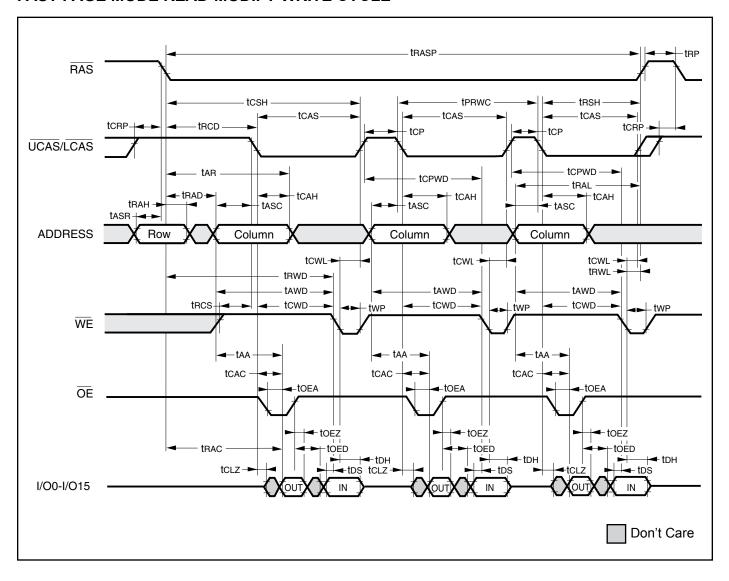


#### Note:

1. toff is referenced from rising edge of  $\overline{RAS}$  or  $\overline{CAS}$ , whichever occurs last.

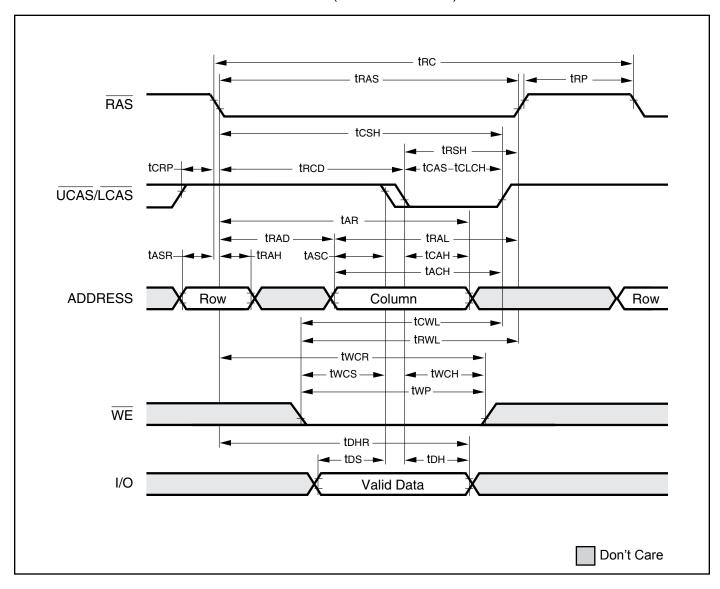


## FAST PAGE MODE READ-MODIFY-WRITE CYCLE



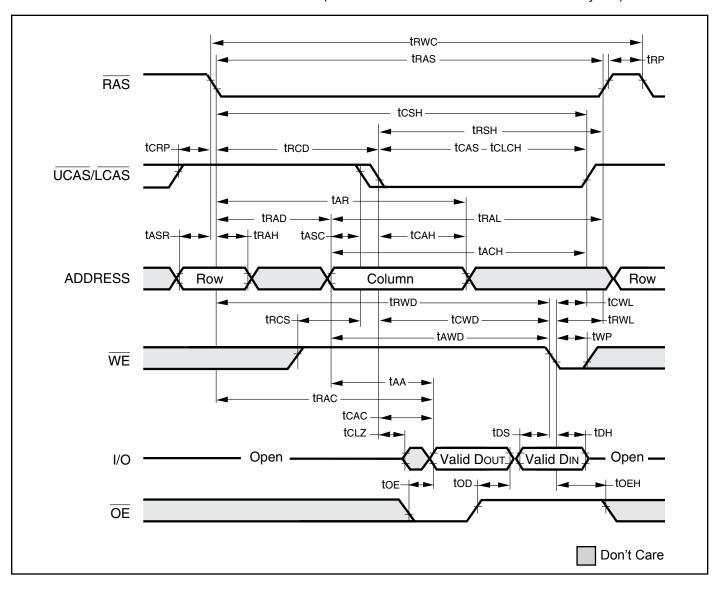


## FAST-PAGE-MODE EARLY WRITE CYCLE (OE = DON'T CARE)



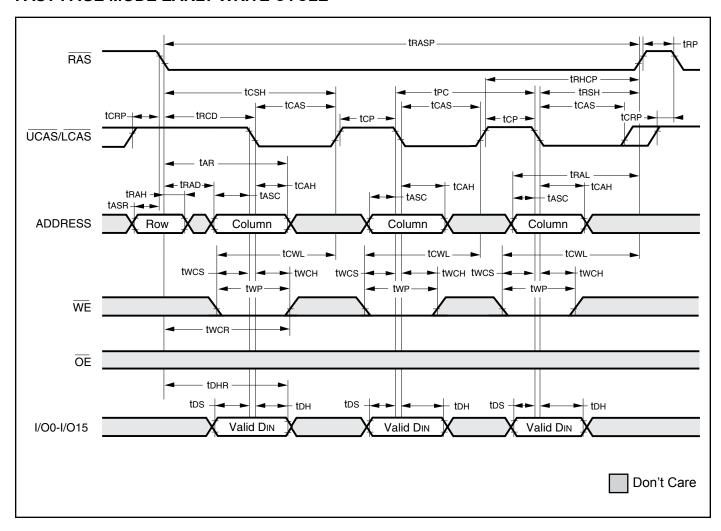


## FAST-PAGE-MODE READ WRITE CYCLE (LATE WRITE and READ-MODIFY-WRITE Cycles)





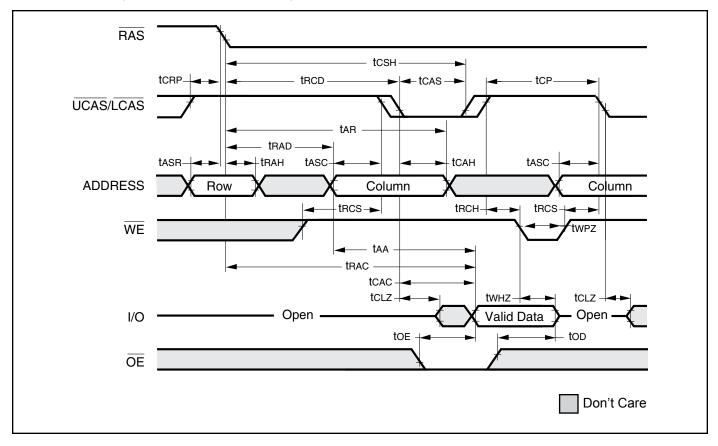
## **FAST PAGE MODE EARLY WRITE CYCLE**



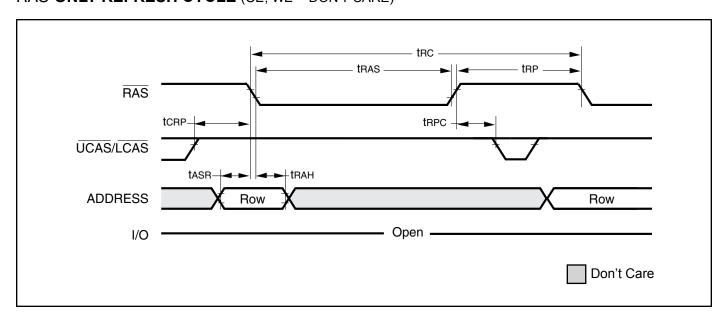


### **AC WAVEFORMS**

## **READ CYCLE** (With WE-Controlled Disable)

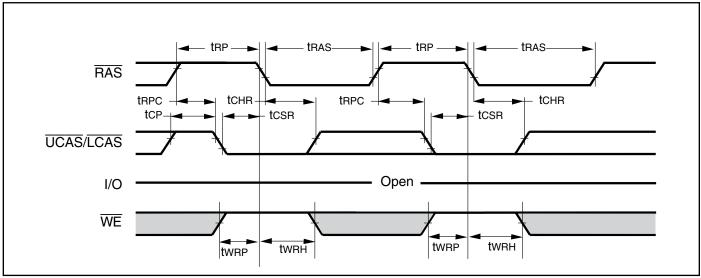


## RAS-ONLY REFRESH CYCLE (OE, WE = DON'T CARE)

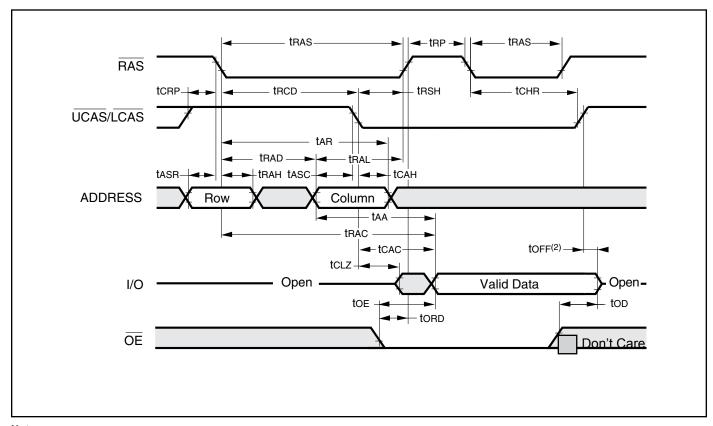




## CBR REFRESH CYCLE (Addresses; OE = DON'T CARE)



## HIDDEN REFRESH CYCLE(1) (WE = HIGH; OE = LOW)



- 1. A Hidden Refresh may also be performed after a Write Cycle. In this case,  $\overline{WE}$  = LOW and  $\overline{OE}$  = HIGH.
- 2. toff is referenced from rising edge of RAS or CAS, whichever occurs last.



## **ORDERING INFORMATION: 5V**

Industrial Range: -40°C to 85°C

| Speed (ns) | Order Part No.    | Package                           |
|------------|-------------------|-----------------------------------|
| 50         | IS41C16105C-50KI  | 400-mil SOJ                       |
|            | IS41C16105C-50KLI | 400-mil SOJ, Lead-free            |
|            | IS41C16105C-50TI  | 400-mil TSOP (Type II)            |
|            | IS41C16105C-50TLI | 400-mil TSOP (Type II), Lead-free |

## **ORDERING INFORMATION: 3.3V**

Industrial Range: -40°C to 85°C

| Speed (ns) | Order Part No.     | Package                           |
|------------|--------------------|-----------------------------------|
| 50         | IS41LV16105C-50KI  | 400-mil SOJ                       |
|            | IS41LV16105C-50KLI | 400-mil SOJ, Lead-free            |
|            | IS41LV16105C-50TI  | 400-mil TSOP (Type II)            |
|            | IS41LV16105C-50TLI | 400-mil TSOP (Type II), Lead-free |

### Note:

The -50 speed option supports 50ns and 60ns timing specifications.



